

<b>Notice of References Cited</b>	Application/Control No. 10/596,214	Applicant(s)/Patent Under Reexamination SHIN ET AL.	
	Examiner JESSE A. ELBIN	Art Unit 2615	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-1,827,919 A	10-1931	<del>WAGENEN JAMES H VAN</del> Van Wagenen	381/419
*	B	US-2002/0146144 A1	10-2002	Armstein, Barry	381/430
*	C	US-2003/0103642 A1	06-2003	Kam, Tai-Yan	381/431
*	D	US-6,810,126 B2	10-2004	Levitsky, Igor	381/431
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.